

3A Dual MOSFET Driver with Low Threshold Input and Enable

Features

- High-Peak Output Current: 3A (typical)
- Wide Input Supply Voltage Operating Range:
 - 4.5 to 18V
- Low Shoot-Through/Cross-Conduction Current in Output Stage
- High Capacitive Load Drive Capability:
 - 1800 pF in 12 ns (typical)
- Short Delay Times: 17 ns (t_{D1}), 21 ns (t_{D2}) (typical)
- Low Supply Current: 620 μ A (typical)
- Low-Voltage Threshold Input and Enable with Hysteresis
- Latch-Up Protected: Withstands 500 mA Reverse Current
- Space-Saving Packages:
 - 8-Lead MSOP
 - 8-Lead SOIC
 - 8-Lead 2 x 3 TDFN

Applications

- Switch Mode Power Supplies
- Pulse Transformer Drive
- Line Drivers
- Level Translator
- Motor and Solenoid Drive

General Description

The MCP14A0303/4/5 devices are high-speed dual MOSFET drivers that are capable of providing up to 3A of peak current while operating from a single 4.5V to 18V supply. There are three output configurations available: dual inverting (MCP14A0303), dual noninverting (MCP14A0304) and complementary (MCP14A0305). These devices feature low shoot-through current, matched rise and fall times, and short propagation delays, which make them ideal for high switching frequency applications.

The MCP14A0303/4/5 family of devices offers enhanced control with enable functionality. The active-high Enable pins can be driven low to drive the corresponding outputs of the MCP14A0303/4/5 low, regardless of the status of the input pins. Integrated pull-up resistors allow the user to leave the Enable pins floating for standard operation.

These devices are highly latch-up resistant under any condition within their power and voltage ratings. They can accept up to 500 mA of reverse current being forced back into their outputs without damage or logic upset. All terminals are fully protected against electrostatic discharge (ESD) up to 2 kV (HBM) and 200V (MM).

Package Types



MCP14A0303/4/5

Functional Block Diagram



1.0 ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings †

| | |
|--|-------------------------------------|
| V_{DD} , Supply Voltage..... | +20V |
| V_{IN} , Input Voltage..... | ($V_{DD} + 0.3V$) to (GND – 0.3V) |
| V_{EN} , Enable Voltage..... | ($V_{DD} + 0.3V$) to (GND – 0.3V) |
| Package Power Dissipation ($T_A = +50^{\circ}C$) | |
| 8L MSOP | 0.63W |
| 8L SOIC | 1.00W |
| 8L 2 x 3 TDFN..... | 1.85W |
| ESD Protection on all pins | 2 kV (HBM) |
| ESD Protection on all pins | 200V (MM) |

† Notice: Stresses above those listed under “Maximum ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

MCP14A0303/4/5

DC CHARACTERISTICS

| Electrical Specifications: Unless otherwise noted, $T_A = +25^\circ\text{C}$, with $4.5\text{V} \leq V_{DD} \leq 18\text{V}$. | | | | | | |
|---|----------------|----------------------------|------|----------------|------------------|--|
| Parameters | Sym. | Min. | Typ. | Max. | Units | Conditions |
| Input | | | | | | |
| Input Voltage Range | V_{IN} | $\text{GND} - 0.3\text{V}$ | — | $V_{DD} + 0.3$ | V | |
| Logic '1' High Input Voltage | V_{IH} | 2.0 | 1.6 | — | V | |
| Logic '0' Low Input Voltage | V_{IL} | — | 1.3 | 0.8 | V | |
| Input Voltage Hysteresis | $V_{HYST(IN)}$ | — | 0.3 | — | V | |
| Input Current | I_{IN} | -1 | — | +1 | μA | $0\text{V} \leq V_{IN} \leq V_{DD}$ |
| Enable | | | | | | |
| Enable Voltage Range | V_{EN} | $\text{GND} - 0.3\text{V}$ | — | $V_{DD} + 0.3$ | V | |
| Logic '1' High Enable Voltage | V_{EH} | 2.0 | 1.6 | — | V | |
| Logic '0' Low Enable Voltage | V_{EL} | — | 1.3 | 0.8 | V | |
| Enable Voltage Hysteresis | $V_{HYST(EN)}$ | — | 0.3 | — | V | |
| Enable Pin Pull-Up Resistance | R_{ENBL} | — | 1.8 | — | $\text{M}\Omega$ | $V_{DD} = 18\text{V}$, $\text{ENB} = A_{\text{GND}}$ |
| Enable Input Current | I_{EN} | — | 12 | — | μA | $V_{DD} = 18\text{V}$, $\text{ENB} = A_{\text{GND}}$ |
| Propagation Delay | t_{D3} | — | 17 | 23 | ns | $V_{DD} = 18\text{V}$, $V_{EN} = 5\text{V}$, see Figure 4-3 (Note 1) |
| Propagation Delay | t_{D4} | — | 21 | 26 | ns | $V_{DD} = 18\text{V}$, $V_{EN} = 5\text{V}$, see Figure 4-3 (Note 1) |
| Output | | | | | | |
| High Output Voltage | V_{OH} | $V_{DD} - 0.025$ | — | — | V | $I_{OUT} = 0\text{A}$ |
| Low Output Voltage | V_{OL} | — | — | 0.025 | V | $I_{OUT} = 0\text{A}$ |
| Output Resistance, High | R_{OH} | — | 2.4 | 4 | Ω | $I_{OUT} = 10\text{ mA}$, $V_{DD} = 18\text{V}$ |
| Output Resistance, Low | R_{OL} | — | 1.6 | 3 | Ω | $I_{OUT} = 10\text{ mA}$, $V_{DD} = 18\text{V}$ |
| Peak Output Current | I_{PK} | — | 3 | — | A | $V_{DD} = 18\text{V}$ (Note 1) |
| Latch-Up Protection Withstand Reverse Current | I_{REV} | 0.5 | — | — | A | Duty cycle $\leq 2\%$, $t \leq 300\ \mu\text{s}$ (Note 1) |
| Switching Time (Note 1) | | | | | | |
| Rise Time | t_R | — | 12 | 17 | ns | $V_{DD} = 18\text{V}$, $C_L = 1800\text{ pF}$, see Figure 4-1 , Figure 4-2 |
| Fall Time | t_F | — | 12 | 17 | ns | $V_{DD} = 18\text{V}$, $C_L = 1800\text{ pF}$, see Figure 4-1 , Figure 4-2 |
| Delay Time | t_{D1} | — | 17 | 23 | ns | $V_{DD} = 18\text{V}$, $V_{IN} = 5\text{V}$, see Figure 4-1 , Figure 4-2 |
| | t_{D2} | — | 21 | 26 | ns | $V_{DD} = 18\text{V}$, $V_{IN} = 5\text{V}$, see Figure 4-1 , Figure 4-2 |
| Power Supply | | | | | | |
| Supply Voltage | V_{DD} | 4.5 | — | 18 | V | |
| Power Supply Current | I_{DD} | — | 620 | 900 | μA | $V_{INA/B} = 3\text{V}$, $V_{ENA/B} = 3\text{V}$ |
| | I_{DD} | — | 620 | 900 | μA | $V_{INA/B} = 0\text{V}$, $V_{ENA/B} = 3\text{V}$ |
| | I_{DD} | — | 620 | 900 | μA | $V_{INA/B} = 3\text{V}$, $V_{ENA/B} = 0\text{V}$ |
| | I_{DD} | — | 620 | 900 | μA | $V_{INA/B} = 0\text{V}$, $V_{ENA/B} = 0\text{V}$ |

Note 1: Tested during characterization, not production tested.

DC CHARACTERISTICS (OVER OPERATING TEMPERATURE RANGE)

| Electrical Specifications: Unless otherwise indicated, over the operating range with $4.5V \leq V_{DD} \leq 18V$. | | | | | | |
|--|----------------|------------------|------|----------------|----------|--|
| Parameters | Sym. | Min. | Typ. | Max. | Units | Conditions |
| Input | | | | | | |
| Input Voltage Range | V_{IN} | GND – 0.3V | — | $V_{DD} + 0.3$ | V | |
| Logic '1' High Input Voltage | V_{IH} | 2.0 | 1.6 | — | V | |
| Logic '0' Low Input Voltage | V_{IL} | — | 1.3 | 0.8 | V | |
| Input Voltage Hysteresis | $V_{HYST(IN)}$ | — | 0.3 | — | V | |
| Input Current | I_{IN} | –10 | — | +10 | μA | $0V \leq V_{IN} \leq V_{DD}$ |
| Enable | | | | | | |
| Enable Voltage Range | V_{EN} | GND – 0.3V | — | $V_{DD} + 0.3$ | V | |
| Logic '1' High Enable Voltage | V_{EH} | 2.0 | 1.6 | — | V | |
| Logic '0' Low Enable Voltage | V_{EL} | — | 1.3 | 0.8 | V | |
| Enable Voltage Hysteresis | $V_{HYST(EN)}$ | — | 0.3 | — | V | |
| Enable Input Current | I_{EN} | — | 12 | — | μA | $V_{DD} = 18V, ENB = A_{GND}$ |
| Propagation Delay | t_{D3} | — | 21 | 27 | ns | $V_{DD} = 18V, V_{EN} = 5V,$ $T_A = +125^\circ C,$ see Figure 4-3 (Note 1) |
| Propagation Delay | t_{D4} | — | 25 | 31 | ns | $V_{DD} = 18V, V_{EN} = 5V,$ $T_A = +125^\circ C,$ see Figure 4-3 (Note 1) |
| Output | | | | | | |
| High Output Voltage | V_{OH} | $V_{DD} - 0.025$ | — | — | V | DC Test |
| Low Output Voltage | V_{OL} | — | — | 0.025 | V | DC Test |
| Output Resistance, High | R_{OH} | — | — | 5 | Ω | $I_{OUT} = 10\text{ mA}, V_{DD} = 18V$ |
| Output Resistance, Low | R_{OL} | — | — | 4 | Ω | $I_{OUT} = 10\text{ mA}, V_{DD} = 18V$ |

Note 1: Tested during characterization, not production tested.

MCP14A0303/4/5

DC CHARACTERISTICS (OVER OPERATING TEMPERATURE RANGE)

| Electrical Specifications: Unless otherwise indicated, over the operating range with $4.5V \leq V_{DD} \leq 18V$. | | | | | | |
|--|----------|------|------|------|---------|---|
| Parameters | Sym. | Min. | Typ. | Max. | Units | Conditions |
| Switching Time (Note 1) | | | | | | |
| Rise Time | t_R | — | 14 | 19 | ns | $V_{DD} = 18V$, $C_L = 1800$ pF, $T_A = +125^\circ C$, see Figure 4-1, Figure 4-2 |
| Fall Time | t_F | — | 14 | 19 | ns | $V_{DD} = 18V$, $C_L = 1800$ pF, $T_A = +125^\circ C$, see Figure 4-1, Figure 4-2 |
| Delay Time | t_{D1} | — | 21 | 27 | ns | $V_{DD} = 18V$, $V_{IN} = 5V$, $T_A = +125^\circ C$, see Figure 4-1, Figure 4-2 |
| | t_{D2} | — | 25 | 31 | ns | $V_{DD} = 18V$, $V_{IN} = 5V$, $T_A = +125^\circ C$, see Figure 4-1, Figure 4-2 |
| Power Supply | | | | | | |
| Supply Voltage | V_{DD} | 4.5 | — | 18 | V | |
| Power Supply Current | I_{DD} | — | — | 1100 | μA | $V_{INA/B} = 3V$, $V_{ENA/B} = 3V$ |
| | I_{DD} | — | — | 1100 | μA | $V_{INA/B} = 0V$, $V_{ENA/B} = 3V$ |
| | I_{DD} | — | — | 1100 | μA | $V_{INA/B} = 3V$, $V_{ENA/B} = 0V$ |
| | I_{DD} | — | — | 1100 | μA | $V_{INA/B} = 0V$, $V_{ENA/B} = 0V$ |

Note 1: Tested during characterization, not production tested.

TEMPERATURE CHARACTERISTICS

| Electrical Specifications: Unless otherwise noted, all parameters apply with $4.5V \leq V_{DD} \leq 18V$ | | | | | | | |
|--|---------------|------|------|------|--------------|----------|--|
| Parameters | Sym. | Min. | Typ. | Max. | Units | Comments | |
| Temperature Ranges | | | | | | | |
| Specified Temperature Range | T_A | -40 | — | +125 | $^\circ C$ | | |
| Maximum Junction Temperature | T_J | — | — | +150 | $^\circ C$ | | |
| Storage Temperature Range | T_A | -65 | — | +150 | $^\circ C$ | | |
| Package Thermal Resistances | | | | | | | |
| Junction-to-Ambient Thermal Resistance, 8LD MSOP | θ_{JA} | — | 158 | — | $^\circ C/W$ | Note 1 | |
| Junction-to-Ambient Thermal Resistance, 8LD SOIC | θ_{JA} | — | 100 | — | $^\circ C/W$ | Note 1 | |
| Junction-to-Ambient Thermal Resistance, 8LD TDFN | θ_{JA} | — | 54 | — | $^\circ C/W$ | Note 1 | |
| Junction-to-Top Characterization Parameter, 8LD MSOP | Ψ_{JT} | — | 2.4 | — | $^\circ C/W$ | Note 1 | |
| Junction-to-Top Characterization Parameter, 8LD SOIC | Ψ_{JT} | — | 5.9 | — | $^\circ C/W$ | Note 1 | |
| Junction-to-Top Characterization Parameter, 8LD TDFN | Ψ_{JT} | — | 0.5 | — | $^\circ C/W$ | Note 1 | |
| Junction-to-Board Characterization Parameter, 8LD MSOP | Ψ_{JB} | — | 115 | — | $^\circ C/W$ | Note 1 | |
| Junction-to-Board Characterization Parameter, 8LD SOIC | Ψ_{JB} | — | 65 | — | $^\circ C/W$ | Note 1 | |
| Junction-to-Board Characterization Parameter, 8LD TDFN | Ψ_{JB} | — | 24 | — | $^\circ C/W$ | Note 1 | |

Note 1: Parameter is determined using High K 2S2P 4-Layer board as described in JESD 51-7, as well as JESD 51-5 for packages with exposed pads.

2.0 TYPICAL PERFORMANCE CURVES

Note: The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore outside the warranted range.

Note: Unless otherwise indicated, $T_A = +25^\circ\text{C}$ with $4.5\text{V} \leq V_{DD} \leq 18\text{V}$.



FIGURE 2-1: Rise Time vs. Supply Voltage.



FIGURE 2-4: Fall Time vs. Capacitive Load.



FIGURE 2-2: Rise Time vs. Capacitive Load.



FIGURE 2-5: Rise and Fall Time vs. Temperature.



FIGURE 2-3: Fall Time vs. Supply Voltage.



FIGURE 2-6: Crossover Current vs. Supply Voltage.

MCP14A0303/4/5

Note: Unless otherwise indicated, $T_A = +25^\circ\text{C}$ with $4.5\text{V} \leq V_{DD} \leq 18\text{V}$.



FIGURE 2-7: *Input Propagation Delay vs. Supply Voltage.*



FIGURE 2-10: *Enable Propagation Delay vs. Supply Voltage.*



FIGURE 2-8: *Input Propagation Delay Time vs. Input Amplitude.*



FIGURE 2-11: *Enable Propagation Delay Time vs. Enable Voltage Amplitude.*



FIGURE 2-9: *Input Propagation Delay vs. Temperature.*



FIGURE 2-12: *Enable Propagation Delay vs. Temperature.*

Note: Unless otherwise indicated, $T_A = +25^\circ\text{C}$ with $4.5\text{V} \leq V_{DD} \leq 18\text{V}$.

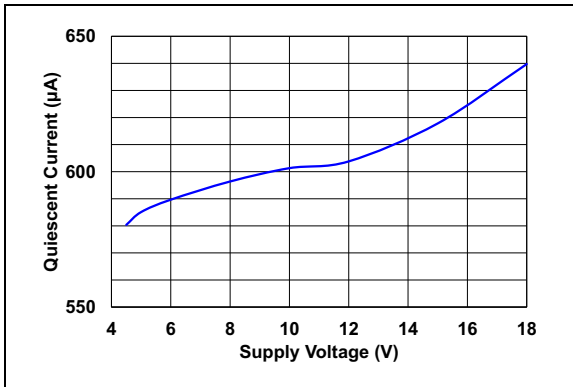


FIGURE 2-13: Quiescent Supply Current vs. Supply Voltage.

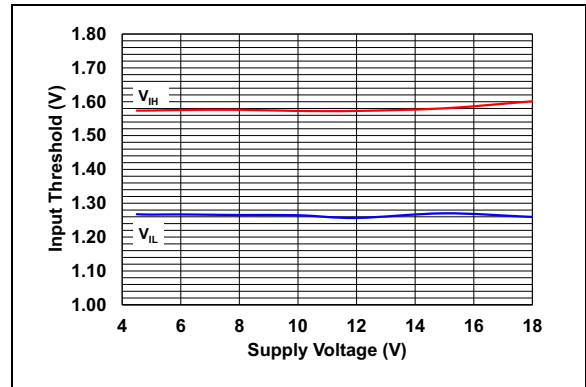


FIGURE 2-16: Input Threshold vs. Supply Voltage.

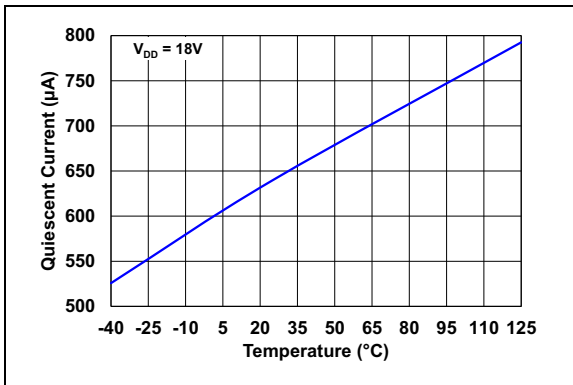


FIGURE 2-14: Quiescent Supply Current vs. Temperature.

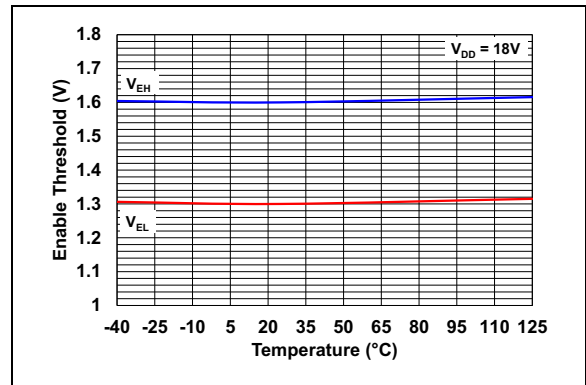


FIGURE 2-17: Enable Threshold vs. Temperature.

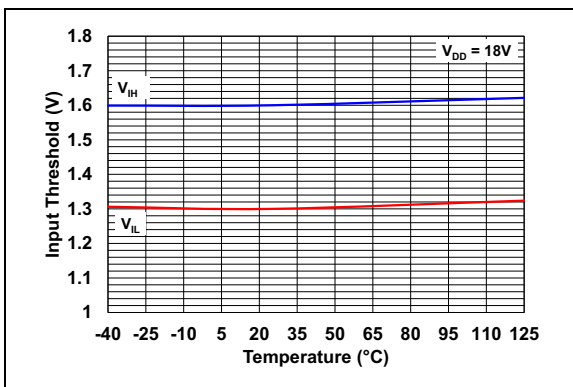


FIGURE 2-15: Input Threshold vs. Temperature.

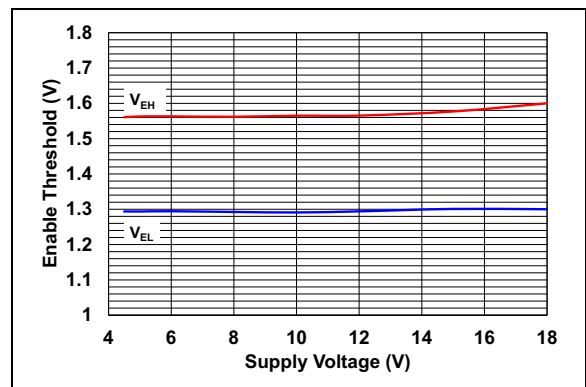


FIGURE 2-18: Enable Threshold vs. Supply Voltage.

MCP14A0303/4/5

Note: Unless otherwise indicated, $T_A = +25^\circ\text{C}$ with $4.5\text{V} \leq V_{DD} \leq 18\text{V}$.



FIGURE 2-19: Output Resistance (Output High) vs. Supply Voltage.



FIGURE 2-22: Supply Current vs. Capacitive Load ($V_{DD} = 12\text{V}$).



FIGURE 2-20: Output Resistance (Output Low) vs. Supply Voltage.



FIGURE 2-23: Supply Current vs. Capacitive Load ($V_{DD} = 6\text{V}$).



FIGURE 2-21: Supply Current vs. Capacitive Load ($V_{DD} = 18\text{V}$).



FIGURE 2-24: Supply Current vs. Frequency ($V_{DD} = 18\text{V}$).

Note: Unless otherwise indicated, $T_A = +25^\circ\text{C}$ with $4.5\text{V} \leq V_{DD} \leq 18\text{V}$.



FIGURE 2-25: Supply Current vs. Frequency ($V_{DD} = 12\text{V}$).



FIGURE 2-26: Supply Current vs. Frequency ($V_{DD} = 6\text{V}$).



FIGURE 2-27: Enable Current vs. Supply Voltage.

MCP14A0303/4/5

NOTES:

3.0 PIN DESCRIPTIONS

The descriptions of the pins are listed in [Table 3-1](#).

TABLE 3-1: PIN FUNCTION TABLE

| MCP14A0303/4/5 | | Symbol | Description |
|----------------|--------------|--|---------------------------|
| 8L 2 x 3 TDFN | 8L MSOP/SOIC | | |
| 1 | 1 | ENA | Enable for Driver A |
| 2 | 2 | INA | Input for Driver A |
| 3 | 3 | GND | Device Ground |
| 4 | 4 | INB | Input for Driver B |
| 5 | 5 | $\overline{\text{OUTB}}/\text{OUTB}/\text{OUTB}$ | Push-Pull for Output B |
| 6 | 6 | V_{DD} | Supply Input Voltage |
| 7 | 7 | $\overline{\text{OUTA}}/\text{OUTA}/\text{OUTA}$ | Push-Pull for Output A |
| 8 | 8 | ENB | Enable for Driver B |
| EP | — | EP | Exposed Thermal Pad (GND) |

3.1 Output Pins ($\overline{\text{OUTA}}/\text{OUTA}/\text{OUTA}$, $\overline{\text{OUTB}}/\text{OUTB}/\text{OUTB}$)

The outputs are CMOS push-pull circuits that are capable of sourcing and sinking 3A of peak current ($V_{DD} = 18V$). The low output impedance ensures the gate of the external MOSFET stays in the intended state, even during large transients. This output also has a reverse current latch-up rating of 500 mA.

3.2 Device Ground Pin (GND)

GND is the device return pin for the input and output stages. The GND pin should have a low-impedance connection to the bias supply source return. When the capacitive load is discharged, high-peak currents flow through the ground pin.

3.3 Device Enable Pins (ENA, ENB)

The MOSFET driver device enable pins are high-impedance inputs featuring low threshold levels. The enable inputs also have hysteresis between the high and low input levels, allowing them to be driven from slow rising and falling signals, and to provide noise immunity. Driving the enable pins below the threshold disables the corresponding output of the device, pulling $\overline{\text{OUT}}/\text{OUT}$ low, regardless of the status of the input pin. Driving the enable pins above the threshold allows normal operation of the $\overline{\text{OUT}}/\text{OUT}$ pin based on the status of the input pin. The enable pins utilize internal pull-up resistors, allowing the pins to be left floating for standard driver operation.

3.4 Control Input Pins (INA, INB)

The MOSFET driver control inputs are high-impedance inputs featuring low threshold levels. The inputs also have hysteresis between the high and low input levels, allowing them to be driven from slow rising and falling signals, and to provide noise immunity.

3.5 Supply Input Pin (V_{DD})

V_{DD} is the bias supply input for the MOSFET driver and has a voltage range of 4.5V to 18V. This input must be decoupled to ground with a local capacitor. This bypass capacitor provides a localized low-impedance path for the peak currents that are provided to the load.

3.6 Exposed Metal Pad Pin (EP)

The exposed metal pad of the TDFN package is internally connected to GND. Therefore, this pad should be connected to a ground plane to aid in heat removal from the package.

MCP14A0303/4/5

NOTES:

4.0 APPLICATION INFORMATION

4.1 General Information

MOSFET drivers are high-speed, high-current devices that are intended to source/sink high-peak currents to charge/discharge the gate capacitance of external MOSFETs or Insulated-Gate Bipolar Transistors (IGBTs). In high-frequency switching power supplies, the Pulse-Width Modulation (PWM) controller may not have the drive capability to directly drive the power MOSFET. A MOSFET driver such as the MCP14A0303/4/5 family can be used to provide additional source/sink current capability.

4.2 MOSFET Driver Timing

The ability of a MOSFET driver to transition from a fully-off state to a fully-on state is characterized by the driver's rise time (t_R), fall time (t_F) and propagation delays (t_{D1} and t_{D2}). Figure 4-1 and Figure 4-2 show the test circuit and timing waveform used to verify the MCP14A0303/4/5 timing.



FIGURE 4-1: Inverting Driver Timing Waveform.



FIGURE 4-2: Noninverting Driver Timing Waveform.

4.3 Enable Function

The enable pins (ENA, ENB) provide additional control of the output pins (OUT). These pins are active-high and are internally pulled up to V_{DD} so that the pins can be left floating to provide standard MOSFET driver operation.

When the enable pin input voltages are above the enable pin high-voltage threshold (V_{EN_H}), the corresponding output is enabled and allowed to react to the status of the input pin. However, when the voltage applied to the enable pins falls below the low threshold voltage (V_{EN_L}), the driver's corresponding output is disabled and does not respond to changes in the status of the input pins. When the driver is disabled, the output is pulled down to a low state. Refer to Table 4-1 for the enable pin logic. The threshold voltage levels for the enable pin are similar to the threshold voltage levels of the input pin and are TTL compatible. Hysteresis is provided to help increase the noise immunity of the enable function, avoiding false triggers of the enable signal during driver switching.

There are propagation delays associated with the driver receiving an enable signal and the output reacting. These propagation delays, t_{D3} and t_{D4} , are graphically represented in Figure 4-3.

MCP14A0303/4/5

TABLE 4-1: ENABLE PIN LOGIC

| EN | IN | $\overline{\text{OUT}}$ | OUT |
|----|----|-------------------------|-----|
| H | H | L | H |
| H | L | H | L |
| L | X | L | L |



FIGURE 4-3: Enable Timing Waveform.

4.4 Decoupling Capacitors

Careful Printed Circuit Board (PCB) layout and decoupling capacitors are required when using power MOSFET drivers. Large current is required to charge and discharge capacitive loads quickly. For example, approximately 720 mA are needed to charge a 1000 pF load with 18V in 25 ns.

To operate the MOSFET driver over a wide frequency range with low supply impedance, it is recommended to place 1.0 μF and 0.1 μF low ESR ceramic capacitors in parallel between the driver V_{DD} and GND. These capacitors should be placed close to the driver to minimize circuit board parasitics and provide a local source for the required current.

4.5 PCB Layout Considerations

Proper PCB layout is important in high-current, fast-switching circuits to provide proper device operation and robustness of design. Improper component placement may cause errant switching, excessive voltage ringing or circuit latch-up. The PCB trace loop length and inductance should be minimized by the use of ground planes or traces under the MOSFET gate drive signal. Separate analog and power grounds and local driver decoupling should also be used.

Placing a ground plane beneath the MCP14A0303/4/5 devices will help as a radiated noise shield, as well as providing some heat sinking for power dissipated within the device.

4.6 Power Dissipation

The total internal power dissipation in a MOSFET driver is the summation of three separate power dissipation elements, as shown in Equation 4-1.

EQUATION 4-1:

$$P_T = P_L + P_Q + P_{CC}$$

Where:

- P_T = Total power dissipation
- P_L = Load power dissipation
- P_Q = Quiescent power dissipation
- P_{CC} = Operating power dissipation

4.6.1 CAPACITIVE LOAD DISSIPATION

The power dissipation caused by a capacitive load is a direct function of the frequency, total capacitive load and supply voltage. The power lost in the MOSFET driver for a complete charging and discharging cycle of a MOSFET is shown in Equation 4-2.

EQUATION 4-2:

$$P_L = f \times C_T \times V_{DD}^2$$

Where:

- f = Switching frequency
- C_T = Total load capacitance
- V_{DD} = MOSFET driver supply voltage

4.6.2 QUIESCENT POWER DISSIPATION

The power dissipation associated with the quiescent current draw depends on the state of the Input and Enable pins. See Section 1.0 “Electrical Characteristics” for typical quiescent current draw values in different operating states. The quiescent power dissipation is shown in Equation 4-3.

EQUATION 4-3:

$$P_Q = (I_{QH} \times D + I_{QL} \times (1 - D)) \times V_{DD}$$

Where:

- I_{QH} = Quiescent current in the High state
- D = Duty cycle
- I_{QL} = Quiescent current in the Low state
- V_{DD} = MOSFET driver supply voltage

4.6.3 OPERATING POWER DISSIPATION

The operating power dissipation occurs each time the MOSFET driver output transitions because, for a very short period of time, both MOSFETs in the output stage are on simultaneously. This cross-conduction current leads to a power dissipation described in [Equation 4-4](#).

EQUATION 4-4:

$$P_{CC} = V_{DD} \times I_{CO}$$

Where:

I_{CO} = Crossover current

V_{DD} = MOSFET driver supply voltage

MCP14A0303/4/5

NOTES:

5.0 PACKAGING INFORMATION

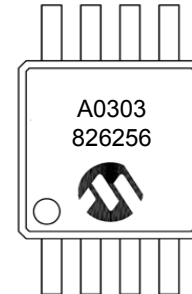
5.1 Package Marking Information

8-Lead MSOP



| Part Number | Code |
|-----------------|-------|
| MCP14A0303-E/MS | A0303 |
| MCP14A0304-E/MS | A0304 |
| MCP14A0305-E/MS | A0305 |

Example:



8-Lead SOIC



| Part Number | Code |
|-----------------|---------|
| MCP14A0303-E/SN | 14A0303 |
| MCP14A0304-E/SN | 14A0304 |
| MCP14A0305-E/SN | 14A0305 |

Example:

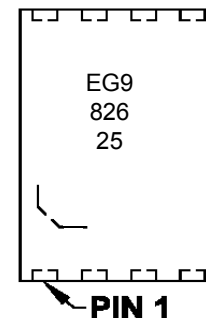


8-Lead TDFN



| Part Number | Code |
|------------------|------|
| MCP14A0303-E/MNY | EG9 |
| MCP14A0304-E/MNY | EH1 |
| MCP14A0305-E/MNY | EH2 |

Example:



| Legend: | XX...X | Customer-specific information |
|---------|--------|--|
| | Y | Year code (last digit of calendar year) |
| | YY | Year code (last 2 digits of calendar year) |
| | WW | Week code (week of January 1 is week '01') |
| | NNN | Alphanumeric traceability code |
| | (e3) | Pb-free JEDEC® designator for Matte Tin (Sn) |
| | * | This package is Pb-free. The Pb-free JEDEC designator (e3) can be found on the outer packaging for this package. |

Note: In the event the full Microchip part number cannot be marked on one line, it will be carried over to the next line, thus limiting the number of available characters for customer-specific information.

MCP14A0303/4/5

8-Lead Plastic Micro Small Outline Package (MS) [MSOP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



Microchip Technology Drawing C04-111C Sheet 1 of 2

8-Lead Plastic Micro Small Outline Package (MS) [MSOP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



| Dimension Limits | Units | MILLIMETERS | | |
|--------------------------|-----------|-------------|------|------|
| | | MIN | NOM | MAX |
| Number of Pins | N | | 8 | |
| Pitch | e | 0.65 BSC | | |
| Overall Height | A | - | - | 1.10 |
| Molded Package Thickness | A2 | 0.75 | 0.85 | 0.95 |
| Standoff | A1 | 0.00 | - | 0.15 |
| Overall Width | E | 4.90 BSC | | |
| Molded Package Width | E1 | 3.00 BSC | | |
| Overall Length | D | 3.00 BSC | | |
| Foot Length | L | 0.40 | 0.60 | 0.80 |
| Footprint | L1 | 0.95 REF | | |
| Foot Angle | φ | 0° | - | 8° |
| Lead Thickness | c | 0.08 | - | 0.23 |
| Lead Width | b | 0.22 | - | 0.40 |

Notes:

- Pin 1 visual index feature may vary, but must be located within the hatched area.
- Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15mm per side.
- Dimensioning and tolerancing per ASME Y14.5M.
 BSC: Basic Dimension. Theoretically exact value shown without tolerances.
 REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-111C Sheet 2 of 2

MCP14A0303/4/5

8-Lead Plastic Micro Small Outline Package (MS) [MSOP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



RECOMMENDED LAND PATTERN

| Dimension Limits | Units | MILLIMETERS | | |
|-------------------------|-------|-------------|------|------|
| | | MIN | NOM | MAX |
| Contact Pitch | E | 0.65 BSC | | |
| Contact Pad Spacing | C | | 4.40 | |
| Overall Width | Z | | | 5.85 |
| Contact Pad Width (X8) | X1 | | | 0.45 |
| Contact Pad Length (X8) | Y1 | | | 1.45 |
| Distance Between Pads | G1 | 2.95 | | |
| Distance Between Pads | GX | 0.20 | | |

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2111A

8-Lead Plastic Small Outline (SN) - Narrow, 3.90 mm Body [SOIC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



Microchip Technology Drawing No. C04-057C Sheet 1 of 2

MCP14A0303/4/5

8-Lead Plastic Small Outline (SN) - Narrow, 3.90 mm Body [SOIC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



| Units | | MILLIMETERS | | |
|--------------------------|----------|-------------|-----|------|
| Dimension Limits | | MIN | NOM | MAX |
| Number of Pins | N | 8 | | |
| Pitch | e | 1.27 BSC | | |
| Overall Height | A | - | - | 1.75 |
| Molded Package Thickness | A2 | 1.25 | - | - |
| Standoff § | A1 | 0.10 | - | 0.25 |
| Overall Width | E | 6.00 BSC | | |
| Molded Package Width | E1 | 3.90 BSC | | |
| Overall Length | D | 4.90 BSC | | |
| Chamfer (Optional) | h | 0.25 | - | 0.50 |
| Foot Length | L | 0.40 | - | 1.27 |
| Footprint | L1 | 1.04 REF | | |
| Foot Angle | ϕ | 0° | - | 8° |
| Lead Thickness | c | 0.17 | - | 0.25 |
| Lead Width | b | 0.31 | - | 0.51 |
| Mold Draft Angle Top | α | 5° | - | 15° |
| Mold Draft Angle Bottom | β | 5° | - | 15° |

Notes:

1. Pin 1 visual index feature may vary, but must be located within the hatched area.
2. § Significant Characteristic
3. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15mm per side.
4. Dimensioning and tolerancing per ASME Y14.5M
BSC: Basic Dimension. Theoretically exact value shown without tolerances.
REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing No. C04-057C Sheet 2 of 2

8-Lead Plastic Small Outline (SN) – Narrow, 3.90 mm Body [SOIC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



RECOMMENDED LAND PATTERN

| | | Units | MILLIMETERS | | |
|-------------------------|----|------------------|-------------|------|------|
| | | Dimension Limits | MIN | NOM | MAX |
| Contact Pitch | E | | 1.27 BSC | | |
| Contact Pad Spacing | C | | | 5.40 | |
| Contact Pad Width (X8) | X1 | | | | 0.60 |
| Contact Pad Length (X8) | Y1 | | | | 1.55 |

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2057A

MCP14A0303/4/5

8-Lead Plastic Dual Flat, No Lead Package (MNY) – 2x3x0.8 mm Body [TDFN] With 1.4x1.3 mm Exposed Pad (JEDEC Package type WDFN)

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



Microchip Technology Drawing No. C04-129-MNY Rev E Sheet 1 of 2

8-Lead Plastic Dual Flat, No Lead Package (MNY) – 2x3x0.8 mm Body [TDFN] With 1.4x1.3 mm Exposed Pad (JEDEC Package type WDFN)

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



| Dimension Limits | Units | MILLIMETERS | | |
|------------------------|-------|-------------|------|------|
| | | MIN | NOM | MAX |
| Number of Pins | N | 8 | | |
| Pitch | e | 0.50 BSC | | |
| Overall Height | A | 0.70 | 0.75 | 0.80 |
| Standoff | A1 | 0.00 | 0.02 | 0.05 |
| Contact Thickness | A3 | 0.20 REF | | |
| Overall Length | D | 2.00 BSC | | |
| Overall Width | E | 3.00 BSC | | |
| Exposed Pad Length | D2 | 1.35 | 1.40 | 1.45 |
| Exposed Pad Width | E2 | 1.25 | 1.30 | 1.35 |
| Contact Width | b | 0.20 | 0.25 | 0.30 |
| Contact Length | L | 0.25 | 0.30 | 0.45 |
| Contact-to-Exposed Pad | K | 0.20 | - | - |

Notes:

- Pin 1 visual index feature may vary, but must be located within the hatched area.
- Package may have one or more exposed tie bars at ends.
- Package is saw singulated
- Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

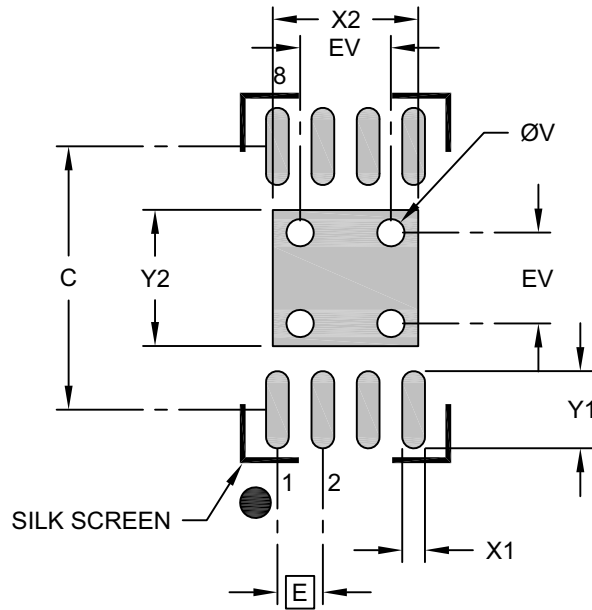
REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing No. C04-129-MNY Rev E Sheet 2 of 2

MCP14A0303/4/5

8-Lead Plastic Dual Flat, No Lead Package (MNY) – 2x3x0.8 mm Body [TDFN] With 1.4x1.3 mm Exposed Pad (JEDEC Package type WDFN)

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



RECOMMENDED LAND PATTERN

| Dimension Limits | Units | MILLIMETERS | | |
|----------------------------|-------|-------------|------|------|
| | | MIN | NOM | MAX |
| Contact Pitch | E | 0.50 BSC | | |
| Optional Center Pad Width | X2 | | | 1.60 |
| Optional Center Pad Length | Y2 | | | 1.50 |
| Contact Pad Spacing | C | | 2.90 | |
| Contact Pad Width (X8) | X1 | | | 0.25 |
| Contact Pad Length (X8) | Y1 | | | 0.85 |
| Thermal Via Diameter | V | | 0.30 | |
| Thermal Via Pitch | EV | | 1.00 | |

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M
BSC: Basic Dimension. Theoretically exact value shown without tolerances.
2. For best soldering results, thermal vias, if used, should be filled or tented to avoid solder loss during reflow process

Microchip Technology Drawing No. C04-129-MNY Rev. B

APPENDIX A: REVISION HISTORY

Revision A (June 2018)

- Original Release of this Document.

MCP14A0303/4/5

NOTES:

PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

| PART NO. | IXI ⁽¹⁾ | -X | /XX |
|--|--------------------|-------------------|---------|
| Device | Tape and Reel | Temperature Range | Package |
| <p>Device:</p> <p>MCP14A0303: High-Speed MOSFET Driver MCP14A0303T: High-Speed MOSFET Driver (Tape and Reel)</p> <p>MCP14A0304: High-Speed MOSFET Driver MCP14A0304T: High-Speed MOSFET Driver (Tape and Reel)</p> <p>MCP14A0305: High-Speed MOSFET Driver MCP14A0305T: High-Speed MOSFET Driver (Tape and Reel)</p> | | | |
| <p>Temperature Range: E = -40°C to +125°C (Extended)</p> | | | |
| <p>Package:</p> <p>MS = Plastic Micro Small Outline Package (MSOP), 8-lead SN = Plastic Small Outline Package (SOIC), 8-lead MNY = Plastic Dual Flat, No Lead Package (TDFN), 8-lead</p> | | | |
| <p>Examples:</p> <p>a) MCP14A0303T-E/MS: Tape and Reel, Extended temperature, 8LD MSOP package</p> <p>b) MCP14A0304T-E/SN: Tape and Reel, Extended temperature, 8LD SOIC package</p> <p>c) MCP14A0305T-E/MNY: Tape and Reel, Extended temperature, 8LD TDFN package</p> | | | |
| <p>Note 1: Tape and Reel identifier only appears in the catalog part number description. This identifier is used for ordering purposes and is not printed on the device package. Check with your Microchip Sales Office for package availability with the Tape and Reel option.</p> | | | |

MCP14A0303/4/5

NOTES:

Note the following details of the code protection feature on Microchip devices:

- Microchip products meet the specification contained in their particular Microchip Data Sheet.
- Microchip believes that its family of products is one of the most secure families of its kind on the market today, when used in the intended manner and under normal conditions.
- There are dishonest and possibly illegal methods used to breach the code protection feature. All of these methods, to our knowledge, require using the Microchip products in a manner outside the operating specifications contained in Microchip's Data Sheets. Most likely, the person doing so is engaged in theft of intellectual property.
- Microchip is willing to work with the customer who is concerned about the integrity of their code.
- Neither Microchip nor any other semiconductor manufacturer can guarantee the security of their code. Code protection does not mean that we are guaranteeing the product as “unbreakable.”

Code protection is constantly evolving. We at Microchip are committed to continuously improving the code protection features of our products. Attempts to break Microchip's code protection feature may be a violation of the Digital Millennium Copyright Act. If such acts allow unauthorized access to your software or other copyrighted work, you may have a right to sue for relief under that Act.

Information contained in this publication regarding device applications and the like is provided only for your convenience and may be superseded by updates. It is your responsibility to ensure that your application meets with your specifications. MICROCHIP MAKES NO REPRESENTATIONS OR WARRANTIES OF ANY KIND WHETHER EXPRESS OR IMPLIED, WRITTEN OR ORAL, STATUTORY OR OTHERWISE, RELATED TO THE INFORMATION, INCLUDING BUT NOT LIMITED TO ITS CONDITION, QUALITY, PERFORMANCE, MERCHANTABILITY OR FITNESS FOR PURPOSE. Microchip disclaims all liability arising from this information and its use. Use of Microchip devices in life support and/or safety applications is entirely at the buyer's risk, and the buyer agrees to defend, indemnify and hold harmless Microchip from any and all damages, claims, suits, or expenses resulting from such use. No licenses are conveyed, implicitly or otherwise, under any Microchip intellectual property rights unless otherwise stated.

Microchip received ISO/TS-16949:2009 certification for its worldwide headquarters, design and wafer fabrication facilities in Chandler and Tempe, Arizona; Gresham, Oregon and design centers in California and India. The Company's quality system processes and procedures are for its PIC® MCUs and dsPIC® DSCs, KEELoc® code hopping devices, Serial EEPROMs, microperipherals, nonvolatile memory and analog products. In addition, Microchip's quality system for the design and manufacture of development systems is ISO 9001:2000 certified.

**QUALITY MANAGEMENT SYSTEM
CERTIFIED BY DNV
= ISO/TS 16949 =**

Trademarks

The Microchip name and logo, the Microchip logo, AnyRate, AVR, AVR logo, AVR Freaks, BitCloud, chipKIT, chipKIT logo, CryptoMemory, CryptoRF, dsPIC, FlashFlex, flexPWR, Helder, JukeBlox, KeeLoq, Klear, LANCheck, LINK MD, maXStylus, maXTouch, MediaLB, megaAVR, MOST, MOST logo, MPLAB, OptoLyzer, PIC, picoPower, PICSTART, PIC32 logo, Prochip Designer, QTouch, SAM-BA, SpyNIC, SST, SST Logo, SuperFlash, tinyAVR, UNI/O, and XMEGA are registered trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

ClockWorks, The Embedded Control Solutions Company, EtherSynch, Hyper Speed Control, HyperLight Load, IntelliMOS, mTouch, Precision Edge, and Quiet-Wire are registered trademarks of Microchip Technology Incorporated in the U.S.A.

Adjacent Key Suppression, AKS, Analog-for-the-Digital Age, Any Capacitor, AnyIn, AnyOut, BodyCom, CodeGuard, CryptoAuthentication, CryptoAutomotive, CryptoCompanion, CryptoController, dsPICDEM, dsPICDEM.net, Dynamic Average Matching, DAM, ECAN, EtherGREEN, In-Circuit Serial Programming, ICSP, INICnet, Inter-Chip Connectivity, JitterBlocker, KlearNet, KlearNet logo, memBrain, Mindi, MiWi, motorBench, MPASM, MPF, MPLAB Certified logo, MPLIB, MPLINK, MultiTRAK, NetDetach, Omniscient Code Generation, PICDEM, PICDEM.net, PICkit, PICtail, PowerSmart, PureSilicon, QMatrix, REAL ICE, Ripple Blocker, SAM-ICE, Serial Quad I/O, SMART-I.S., SQI, SuperSwitcher, SuperSwitcher II, Total Endurance, TSHARC, USBCheck, VariSense, ViewSpan, WiperLock, Wireless DNA, and ZENA are trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

SQTP is a service mark of Microchip Technology Incorporated in the U.S.A.

Silicon Storage Technology is a registered trademark of Microchip Technology Inc. in other countries.

GestIC is a registered trademark of Microchip Technology Germany II GmbH & Co. KG, a subsidiary of Microchip Technology Inc., in other countries.

All other trademarks mentioned herein are property of their respective companies.

© 2018, Microchip Technology Incorporated, All Rights Reserved.
ISBN: 978-1-5224-3269-2



MICROCHIP

Worldwide Sales and Service

AMERICAS

Corporate Office
2355 West Chandler Blvd.
Chandler, AZ 85224-6199
Tel: 480-792-7200
Fax: 480-792-7277
Technical Support:
<http://www.microchip.com/support>
Web Address:
www.microchip.com

Atlanta

Duluth, GA
Tel: 678-957-9614
Fax: 678-957-1455

Austin, TX

Tel: 512-257-3370

Boston

Westborough, MA
Tel: 774-760-0087
Fax: 774-760-0088

Chicago

Itasca, IL
Tel: 630-285-0071
Fax: 630-285-0075

Dallas

Addison, TX
Tel: 972-818-7423
Fax: 972-818-2924

Detroit

Novi, MI
Tel: 248-848-4000

Houston, TX

Tel: 281-894-5983

Indianapolis

Noblesville, IN
Tel: 317-773-8323
Fax: 317-773-5453
Tel: 317-536-2380

Los Angeles

Mission Viejo, CA
Tel: 949-462-9523
Fax: 949-462-9608
Tel: 951-273-7800

Raleigh, NC

Tel: 919-844-7510

New York, NY

Tel: 631-435-6000

San Jose, CA

Tel: 408-735-9110
Tel: 408-436-4270

Canada - Toronto

Tel: 905-695-1980
Fax: 905-695-2078

ASIA/PACIFIC

Australia - Sydney
Tel: 61-2-9868-6733

China - Beijing
Tel: 86-10-8569-7000

China - Chengdu
Tel: 86-28-8665-5511

China - Chongqing
Tel: 86-23-8980-9588

China - Dongguan
Tel: 86-769-8702-9880

China - Guangzhou
Tel: 86-20-8755-8029

China - Hangzhou
Tel: 86-571-8792-8115

China - Hong Kong SAR
Tel: 852-2943-5100

China - Nanjing
Tel: 86-25-8473-2460

China - Qingdao
Tel: 86-532-8502-7355

China - Shanghai
Tel: 86-21-3326-8000

China - Shenyang
Tel: 86-24-2334-2829

China - Shenzhen
Tel: 86-755-8864-2200

China - Suzhou
Tel: 86-186-6233-1526

China - Wuhan
Tel: 86-27-5980-5300

China - Xian
Tel: 86-29-8833-7252

China - Xiamen
Tel: 86-592-2388138

China - Zhuhai
Tel: 86-756-3210040

ASIA/PACIFIC

India - Bangalore
Tel: 91-80-3090-4444

India - New Delhi
Tel: 91-11-4160-8631

India - Pune
Tel: 91-20-4121-0141

Japan - Osaka
Tel: 81-6-6152-7160

Japan - Tokyo
Tel: 81-3-6880-3770

Korea - Daegu
Tel: 82-53-744-4301

Korea - Seoul
Tel: 82-2-554-7200

Malaysia - Kuala Lumpur
Tel: 60-3-7651-7906

Malaysia - Penang
Tel: 60-4-227-8870

Philippines - Manila
Tel: 63-2-634-9065

Singapore
Tel: 65-6334-8870

Taiwan - Hsin Chu
Tel: 886-3-577-8366

Taiwan - Kaohsiung
Tel: 886-7-213-7830

Taiwan - Taipei
Tel: 886-2-2508-8600

Thailand - Bangkok
Tel: 66-2-694-1351

Vietnam - Ho Chi Minh
Tel: 84-28-5448-2100

EUROPE

Austria - Wels
Tel: 43-7242-2244-39
Fax: 43-7242-2244-393

Denmark - Copenhagen
Tel: 45-4450-2828
Fax: 45-4485-2829

Finland - Espoo
Tel: 358-9-4520-820

France - Paris
Tel: 33-1-69-53-63-20
Fax: 33-1-69-30-90-79

Germany - Garching
Tel: 49-8931-9700

Germany - Haan
Tel: 49-2129-3766400

Germany - Heilbronn
Tel: 49-7131-67-3636

Germany - Karlsruhe
Tel: 49-721-625370

Germany - Munich
Tel: 49-89-627-144-0
Fax: 49-89-627-144-44

Germany - Rosenheim
Tel: 49-8031-354-560

Israel - Ra'anana
Tel: 972-9-744-7705

Italy - Milan
Tel: 39-0331-742611
Fax: 39-0331-466781

Italy - Padova
Tel: 39-049-7625286

Netherlands - Drunen
Tel: 31-416-690399
Fax: 31-416-690340

Norway - Trondheim
Tel: 47-7289-7561

Poland - Warsaw
Tel: 48-22-3325737

Romania - Bucharest
Tel: 40-21-407-87-50

Spain - Madrid
Tel: 34-91-708-08-90
Fax: 34-91-708-08-91

Sweden - Gothenberg
Tel: 46-31-704-60-40

Sweden - Stockholm
Tel: 46-8-5090-4654

UK - Wokingham
Tel: 44-118-921-5800
Fax: 44-118-921-5820

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Microchip:

[MCP14A0304-E/MNY](#) [MCP14A0304T-E/MS](#) [MCP14A0305T-E/MS](#) [MCP14A0303-E/SN](#) [MCP14A0304T-E/SN](#)
[MCP14A0305-E/MS](#) [MCP14A0305-E/MNY](#) [MCP14A0303T-E/MS](#) [MCP14A0303-E/MS](#) [MCP14A0305T-E/MNY](#)
[MCP14A0303-E/MNY](#) [MCP14A0303T-E/MNY](#) [MCP14A0304-E/SN](#) [MCP14A0304-E/MS](#) [MCP14A0304T-E/MNY](#)
[MCP14A0305-E/SN](#) [MCP14A0305T-E/SN](#) [MCP14A0303T-E/SN](#)



Стандарт Электрон Связь

Мы молодая и активно развивающаяся компания в области поставок электронных компонентов. Мы поставляем электронные компоненты отечественного и импортного производства напрямую от производителей и с крупнейших складов мира.

Благодаря сотрудничеству с мировыми поставщиками мы осуществляем комплексные и плановые поставки широчайшего спектра электронных компонентов.

Собственная эффективная логистика и склад в обеспечивает надежную поставку продукции в точно указанные сроки по всей России.

Мы осуществляем техническую поддержку нашим клиентам и предпродажную проверку качества продукции. На все поставляемые продукты мы предоставляем гарантию .

Осуществляем поставки продукции под контролем ВП МО РФ на предприятия военно-промышленного комплекса России , а также работаем в рамках 275 ФЗ с открытием отдельных счетов в уполномоченном банке. Система менеджмента качества компании соответствует требованиям ГОСТ ISO 9001.

Минимальные сроки поставки, гибкие цены, неограниченный ассортимент и индивидуальный подход к клиентам являются основой для выстраивания долгосрочного и эффективного сотрудничества с предприятиями радиоэлектронной промышленности, предприятиями ВПК и научно-исследовательскими институтами России.

С нами вы становитесь еще успешнее!

Наши контакты:

Телефон: +7 812 627 14 35

Электронная почта: sales@st-electron.ru

Адрес: 198099, Санкт-Петербург,
Промышленная ул, дом № 19, литера Н,
помещение 100-Н Офис 331